

Issue Classification

Don J. Ahern 7-20-06
(Assistant Examiner) (Date)

(Legal Instruments Examiner) 8-7-06 (Date)

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Total Claims Allowed: 12

O.G.
Print Claim(s)

O.G.
Print Fig.

12☒ Claims renumbered in the same order as presented by applicant☐ CPA☐ T.D.

☐ R.1.47

[illegible]